

Diffuse Reflection Imaging for Detection of Surface Defect Based on Machine Learning

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ABSTRACT

Diffuse reflection imaging relies on the fundamental principles of light interaction with rough or matte surfaces, enabling light to scatter in various directions. Unlike specular reflection, which directs light in a single path, diffuse reflection occurs sporadically. Its distinctive quality lies in its effectiveness for imaging objects with irregular or non-reflective surfaces, offering comprehensive information challenging to attain through alternative imaging methods. As a burgeoning subfield within optical and computer vision technologies, diffuse reflection imaging holds immense potential across scientific, industrial, and medical domains. This abstract succinctly outlines the key aspects of diffuse reflection imaging and underscores its diverse applications, marking it as a promising and newly developed field with substantial implications.

Key words : Detection, Machine Learning, Reflection, Diffuse and Specular

1. INTRODUCTION

Diffuse reflection occurs when light scatters from a surface at various angles, differing from the singular direction of specular reflection. Unlike specular reflection, which influences image perception by focusing incident light on an object's surface, diffuse reflection disperses light or waves across the surface, significantly impacting image visibility, realism, and vibrancy[1]. The concept of lambertian reflectance is crucial for understanding diffuse reflection and serves as the basis for achieving uniform lighting in various imaging applications. It helps in comprehending how non-emitting objects become visible, as our eyes interact with diffusely scattered light to form a coherent image of our surroundings[2][3]. In computer vision, computer graphics, and remote sensing, diffuse reflection imaging plays a pivotal role in capturing and analyzing the appearance of surfaces exhibiting diffuse reflection[3]. Unlike specular reflection,

which occurs at a fixed angle, diffuse reflection arises when light scatters in various directions upon striking a rough or irregular surface. This imaging technique is particularly valuable for examining surfaces with intricate textures and roughness, such as those found in paper, textiles, and natural materials like stone and wood. The microscopic interaction between light and a surface in diffuse reflection involves absorption and subsequent reemission in multiple directions, resulting in a smooth and uniform appearance without discernible highlights or shadows[7]. Ongoing advancements in diffuse reflection imaging techniques contribute to the realism of computer-generated images and the precision of surface analysis, shaping the evolution of computer vision, computer graphics, and remote sensing technologies. The innovations in this paper involve using both the grey code and a 4-step phase shift technique to accurately resolve the absolute segment of the considered image. The process of identifying image defects includes absolute segment conversion, gradient calculation, affine transformation for angle correction, a module matching approach for detecting diffuse reflection surface defects, and applying grey morphological opening and closing operations to the original image to obtain detailed information about the disorder's morphology and position[1][9]. Simulation results demonstrate that the proposed technique not only enhances the accuracy of diffuse reflection surface defect detection but also concurrently reduces the overall cost associated with disorder identification. These advancements hold practical significance, offering improved accuracy and cost-effectiveness in applications requiring diffuse reflection surface defect detection processes[6][10].

2. LITERATURE REVIEW

1. A Diffuse Reflection Approach for Detection of Surface Defect Using Machine Learning in 2022, the focus is on addressing the challenges posed by irregular diffuse reflection on surfaces, particularly in industrial settings where rapid advancements have become integral[15]. The presence

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